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Kind regards,

Team Nexperia



100 V, 1 A PNP low V_{CEsat} (BISS) transistor Rev. 02 — 22 November 2009

Product data sheet

Product profile

1.1 General description

PNP low V_{CEsat} Breakthrough In Small Signal (BISS) transistor in a SOT89 (SC-62/ TO-243) SMD plastic package.

NPN complement: PBSS8110X.

1.2 Features

- SOT89 package
- Low collector-emitter saturation voltage V_{CEsat}
- High collector current capability I_C and I_{CM}
- High efficiency leading to less heat generation

1.3 Applications

- Major application segments:
 - Automotive 42 V power
 - ◆ Telecom infrastructure
 - Industrial
- Peripheral driver:
 - ◆ Driver in low supply voltage applications (e.g. lamps and LEDs)
 - ◆ Inductive load driver (e.g. relays, buzzers and motors)
- DC-to-DC conversion

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{CEO}	collector-emitter voltage	open base	-	-	-100	V
I _C	collector current (DC)		-	-	-1	Α
I _{CM}	peak collector current	single pulse; $t_p \le 1 \text{ ms}$	-	-	-3	Α
R _{CEsat}	collector-emitter saturation resistance	$I_{C} = -1 A;$ $I_{B} = -100 \text{ mA}$	[1] -	170	320	mΩ

^[1] Pulse test: $t_p \le 300 \ \mu s; \ \delta \le 0.02.$



100 V, 1 A PNP low V_{CEsat} (BISS) transistor

2. Pinning information

Table 2. Pinning

Table 2.	ı ıııını	
Pin	Description	Simplified outline Symbol
1	emitter	
2	collector	2
3	base	3 2 1
		006aaa231

3. Ordering information

Table 3. Ordering information

Type number			
	Name	Description	Version
PBSS9110X	SC-62	plastic surface mounted package; collector pad for good heat transfer; 3 leads	SOT89

4. Marking

Table 4. Marking codes

Type number	Marking code ^[1]
PBSS9110X	*4C

[1] * = -: made in Hong Kong

* = p: made in Hong Kong

* = t: made in Malaysia

* = W: made in China

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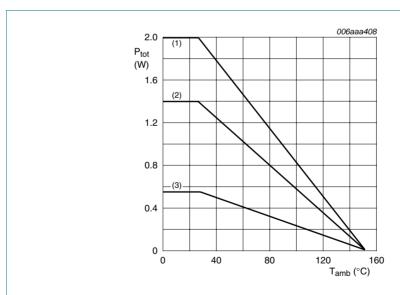
Limiting values 5.

Table 5. **Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V_{CBO}	collector-base voltage	open emitter		-	-120	V
V_{CEO}	collector-emitter voltage	open base		-	-100	V
V_{EBO}	emitter-base voltage	open collector		-	-5	V
I _C	collector current (DC)			-	-1	Α
I _{CM}	peak collector current	$\begin{array}{l} \text{single pulse;} \\ t_p \leq 1 \text{ ms} \end{array}$		-	-3	Α
I _B	base current (DC)			-	-0.3	Α
P _{tot}	total power dissipation	$T_{amb} \le 25 ^{\circ}C$	[1]	-	0.55	W
			[2]	-	1.4	W
			[3]	-	2.0	W
Tj	junction temperature			-	150	°C
T _{amb}	ambient temperature			-65	+150	°C
T _{stg}	storage temperature			-65	+150	°C

- [1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated, standard footprint.
- Device mounted on an FR4 PCB, single-sided copper, tin-plated, 6cm² collector mounting pad.
- Device mounted on a ceramic PCB, Al₂O₃, standard footprint.



- (1) Ceramic PCB, Al₂O₃, standard footprint
- (2) FR4 PCB, mounting pad for collector 6cm²
- (3) FR4 PCB, standard footprint

Fig 1. **Power derating curves**

Product data sheet



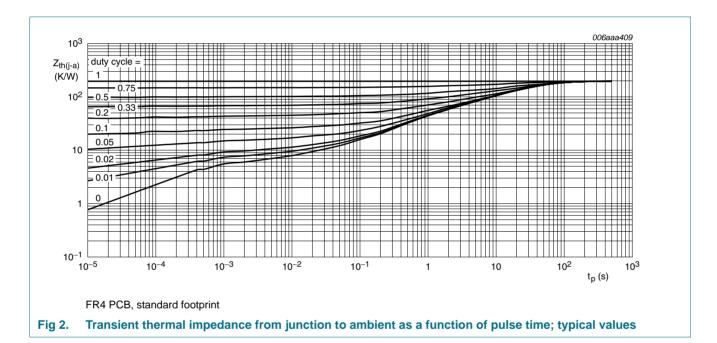
100 V, 1 A PNP low V_{CEsat} (BISS) transistor

6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-a)}$	thermal resistance from	in free air	<u>[1]</u> -	-	227	K/W
	junction to ambient		[2]	-	89	K/W
			[3]	-	63	K/W
$R_{th(j-sp)}$	thermal resistance from junction to solder point		-	-	16	K/W

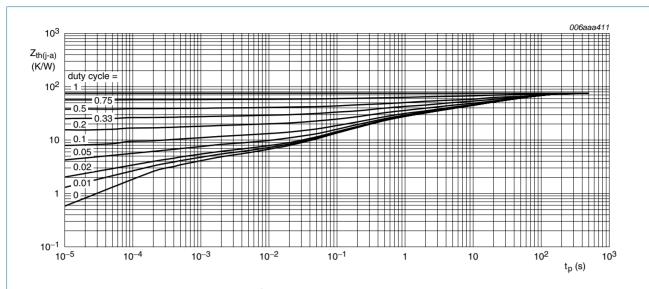
- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6cm².
- [3] Device mounted on a ceramic PCB, AL₂O₃, standard footprint.



PBSS9110X_2

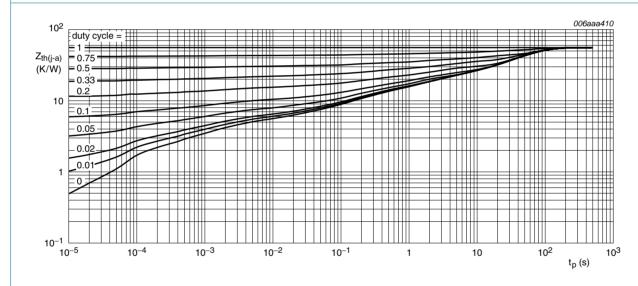
PBSS9110X NXP Semiconductors

100 V, 1 A PNP low V_{CEsat} (BISS) transistor



FR4 PCB, mounting pad for collector 6cm²

Fig 3. Transient thermal impedance from junction to ambient as a function of pulse time; typical values



Ceramic PCB, Al₂O₃, standard footprint

Fig 4. Transient thermal impedance from junction to ambient as a function of pulse time; typical values

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100 V, 1 A PNP low V_{CEsat} (BISS) transistor

Characteristics

Table 7. Characteristics

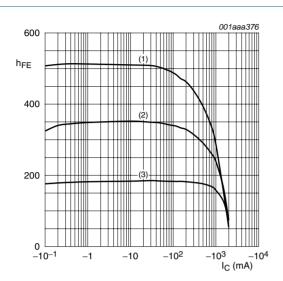
 $T_{amb} = 25 \, ^{\circ}\text{C}$ unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I _{CBO}	collector-base cut-off	$V_{CB} = -80 \text{ V}; I_E = 0 \text{ A}$	-	-	-100	nΑ
	current	$V_{CB} = -80 \text{ V}; I_E = 0 \text{ A};$ $T_j = 150 \text{ °C}$	-	-	-50	μА
I _{CES}	collector-emitter cut-off current	$V_{CE} = -80 \text{ V}; V_{BE} = 0 \text{ V}$	-	-	-100	nA
I _{EBO}	emitter-base cut-off current	$V_{EB} = -4 \text{ V}; I_C = 0 \text{ A}$	-	-	-100	nA
h _{FE}	DC current gain	$V_{CE} = -5 \text{ V}; I_{C} = -1 \text{ mA}$	150	-	-	
		$V_{CE} = -5 \text{ V}; I_{C} = -250 \text{ mA}$	150	-	-	
		$V_{CE} = -5 \text{ V}; I_{C} = -0.5 \text{ A}$	<u>11</u> 150	-	450	
		$V_{CE} = -5 \text{ V}; I_{C} = -1 \text{ A}$	125	-	-	
V _{CEsat}	collector-emitter saturation voltage	$I_C = -250 \text{ mA};$ $I_B = -25 \text{ mA}$	-	-	-120	mV
		$I_C = -500 \text{ mA};$ $I_B = -50 \text{ mA}$	-	-	-180	mV
		$I_C = -1 A$; $I_B = -100 \text{ mA}$	[1] _	-	-320	mV
R _{CEsat}	collector-emitter saturation resistance	$I_C = -1 A$; $I_B = -100 \text{ mA}$	[1] -	170	320	mΩ
V_{BEsat}	base-emitter saturation voltage	$I_C = -1 A$; $I_B = -100 \text{ mA}$	-	-	-1.1	V
V_{BEon}	base-emitter turn-on voltage	$I_C = -1 A$; $V_{CE} = -5 V$	-	-	-1.0	V
t _d	delay time	$V_{CC} = -10 \text{ V}; I_C = -0.5 \text{ A};$	-	20	-	ns
t _r	rise time	$I_{Bon} = -0.025 \text{ A};$	-	60	-	ns
t _{on}	turn-on time	$I_{Boff} = 0.025 A$	-	80	-	ns
ts	storage time		-	290	-	ns
t _f	fall time		-	120	-	ns
t _{off}	turn-off time		-	410	-	ns
f _T	transition frequency	$I_C = -50 \text{ mA}; V_{CE} = -10 \text{ V};$ $f = 100 \text{ MHz}$	100	-	-	MHz
C _c	collector capacitance	$I_E = i_e = 0 \text{ A}; V_{CB} = -10 \text{ V};$ f = 1 MHz	-	-	17	pF

^[1] Pulse test: $t_p \le 300~\mu s;~\delta \le 0.02.$

Product data sheet

100 V, 1 A PNP low V_{CEsat} (BISS) transistor



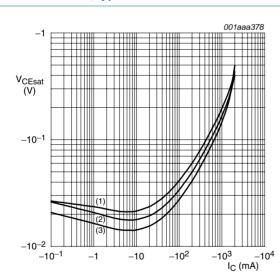
$$V_{CE} = -10 \text{ V}$$

(1)
$$T_{amb} = 100 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3)
$$T_{amb} = -55 \, ^{\circ}C$$

Fig 5. DC current gain as a function of collector current; typical values



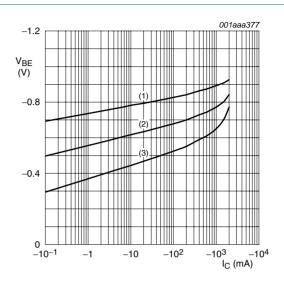
$$I_{\rm C}/I_{\rm B} = 10$$

(1)
$$T_{amb} = 100 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3)
$$T_{amb} = -55 \, ^{\circ}C$$

Fig 7. Collector-emitter saturation voltage as a function of collector current; typical values



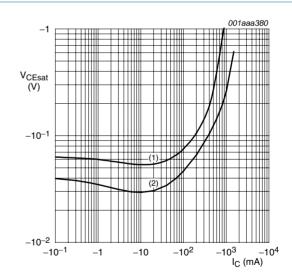
$$V_{CE} = -10 \text{ V}$$

(1)
$$T_{amb} = -55 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3)
$$T_{amb} = 100 \, ^{\circ}C$$

Fig 6. Base-emitter voltage as a function of collector current; typical values



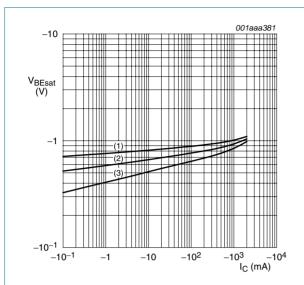
$$T_{amb} = 25 \, ^{\circ}C$$

(1)
$$I_C/I_B = 50$$

(2)
$$I_C/I_B = 20$$

Fig 8. Collector-emitter saturation voltage as a function of collector current; typical values

100 V, 1 A PNP low V_{CEsat} (BISS) transistor



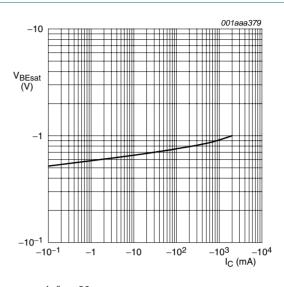
$$I_{\rm C}/I_{\rm B} = 10$$

(1)
$$T_{amb} = -55 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3)
$$T_{amb} = 100 \, ^{\circ}C$$

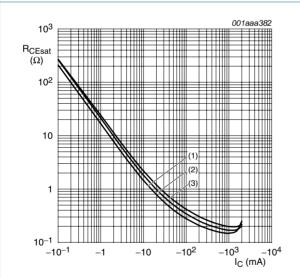
Fig 9. Base-emitter saturation voltage as a function of collector current; typical values



$$I_C/I_B = 20$$

 $T_{amb} = 25 \, ^{\circ}C$

Fig 10. Base-emitter saturation voltage as a function of collector current; typical values



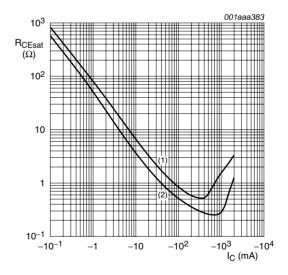
$$I_{\rm C}/I_{\rm B} = 10$$

(1)
$$T_{amb} = -55 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3)
$$T_{amb} = 100 \, ^{\circ}C$$

Fig 11. Collector-emitter saturation resistance as a function of collector current; typical values



$$T_{amb} = 25 \, ^{\circ}C$$

(1)
$$I_C/I_B = 50$$

(2)
$$I_C/I_B = 20$$

Fig 12. Collector-emitter saturation resistance as a function of collector current; typical values

Product data sheet

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100 V, 1 A PNP low V_{CEsat} (BISS) transistor

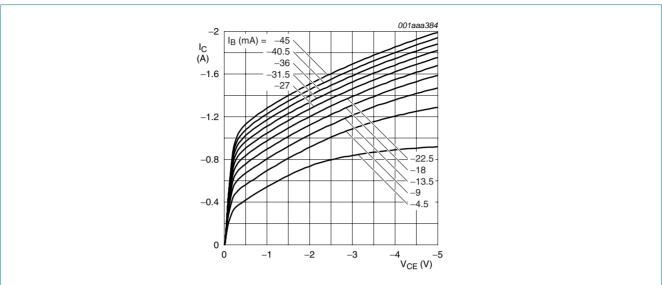


Fig 13. Collector current as a function of collector-emitter voltage; typical values

8. Test information

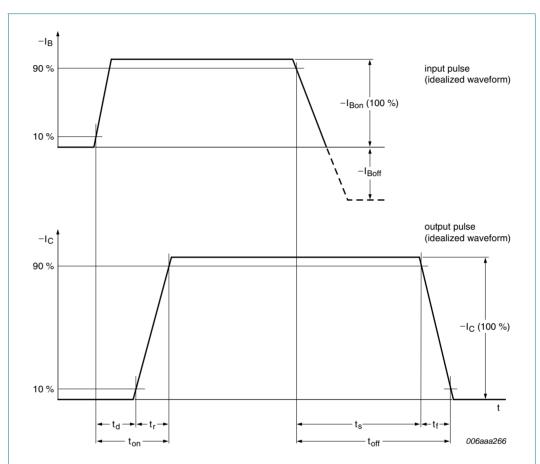
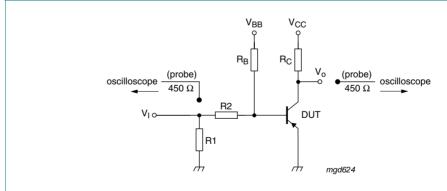


Fig 14. BISS transistor switching time definition



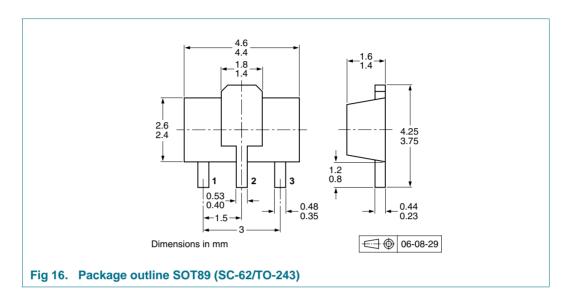
 $V_{CC} = -10 \text{ V}; I_C = -0.5 \text{ A}; I_{Bon} = -0.025 \text{ A}; I_{Boff} = 0.025 \text{ A}$

Fig 15. Test circuit for switching times

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100 V, 1 A PNP low V_{CEsat} (BISS) transistor

Package outline 9.



10. Packing information

Product data sheet

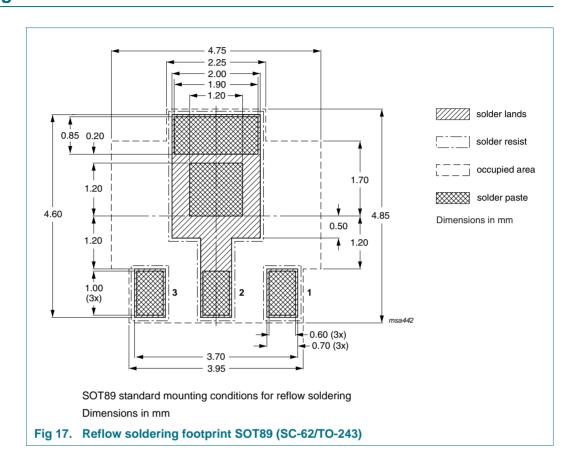
Table 8. **Packing methods**

The indicated -xxx are the last three digits of the 12NC ordering code.[1]

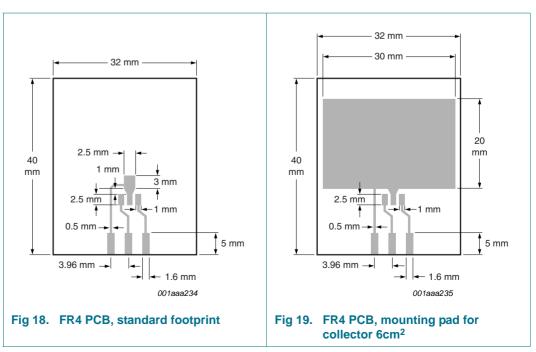
Type number	Package Description		Packing qu	ıantity
			1000	4000
PBSS9110X	SOT89	8 mm pitch, 12 mm tape and reel	-115	-135

[1] For further information and the availability of packing methods, see Section 15.

11. Soldering



12. Mounting



100 V, 1 A PNP low V_{CEsat} (BISS) transistor

13. Revision history

Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes	
PBSS9110X_2	20091122	Product data sheet	-	PBSS9110X_1	
Modifications:	ne NXP Semiconductors, vere made to the technical				
	 Figure 12 "Collector-emitter saturation resistance as a function of collector curvalues": updated 				
	 Figure 13 "C updated 	Collector current as a function	on of collector-emitter	voltage; typical values":	
PBSS9110X_1	20050502	Product data sheet	-	-	

NXP Semiconductors PBSS9110X

100 V, 1 A PNP low V_{CEsat} (BISS) transistor

14. Legal information

14.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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- [2] The term 'short data sheet' is explained in section "Definitions"
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